







SN74LV4T125 SCLS749C - FEBRUARY 2014 - REVISED JUNE 2022

SN74LV4T125 Single Power Supply Quadruple Buffer Translator GATE With 3-State **Output CMOS Logic Level Shifter**

1 Features

- Single-Supply Voltage Translator at 5.0-V, 3.3-V, 2.5-V, and 1.8-V V_{CC}
- Operating Range of 1.8 V to 5.5 V
- Up Translation
 - 1.2 V⁽¹⁾ to 1.8 V at 1.8-V V_{CC}
 - 1.5 V⁽¹⁾ to 2.5 V at 2.5-V V_{CC}
 - 1.8 V⁽¹⁾ to 3.3 V at 3.3-V V_{CC}
 - 3.3 V to 5.0 V at 5.0-V V_{CC}
- **Down Translation**
 - 3.3 V to 1.8 V at 1.8-V V_{CC}
 - 3.3 V to 2.5 V at 2.5-V V_{CC}
 - 5.0 V to 3.3 V at 3.3-V V_{CC}
- Logic Output is Referenced to V_{CC}
- Characterized up to 50 MHz at 3.3-V V_{CC}
- 5.5 V Tolerance on Input Pins
- -40°C to 125°C Operating Temperature Range
- Pb-Free Packages Available: SC-70 (RGY) - 3.5 × 3.5 × 1 mm
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- Supports Standard Logic Pinouts
- Ioff Support Partial-Power-Down Mode Operation
- CMOS Output B Compatible with AUP125, LVC125¹

2 Applications

- Tablet
- Smartphone
- Personal Computer
- Industrial Automotive

3 Description

SN74LV4T125 is a low-voltage CMOS buffer gate that operates at a wider voltage range for portable, telecom, industrial, and automotive applications. The output level is referenced to the supply voltage and is able to support 1.8-V, 2.5-V, 3.3-V, and 5-V CMOS levels.

The input is designed with a lower threshold circuit to match 1.8-V input logic at V_{CC} = 3.3 V and can be used in 1.8 V to 3.3 V level-up translation. In addition, the 5-V tolerant input pins enable down translation (for example, 3.3 V to 2.5 V output at V_{CC} = 2.5 V). The wide V_{CC} range of 1.8 V to 5.5 V allows the generation of desired output levels to connect to controllers or processors.

The SN74LV4T125 device is designed with currentdrive capability of 8 mA to reduce line reflections, overshoot, and undershoot caused by high-drive outputs.

Device Information

PART NUMBER ⁽¹⁾	PACKAGE	BODY SIZE (NOM)		
SN74LV4T125	PW (TSSOP, 14)	5.00 mm x 4.40 mm		
311742041123	RGY (VQFN, 14)	3.50 mm x 3.50 mm		

For all available packages, see the orderable addendum at (1)the end of the data sheet.

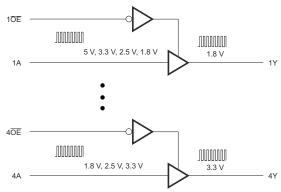


Figure 3-1. Simplified Application Diagram

¹ Refer the V_{IH}/V_{IL} and output drive for lower V_{CC} condition.

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.



Table of Contents

1 Features 2 Applications	1
3 Description	
4 Revision History	2
5 Pin Configuration and Functions	3
Pin Functions	3
6 Specifications	4
6.1 Absolute Maximum Ratings	4
6.2 ESD Ratings	
6.3 Recommended Operating Conditions	
6.4 Thermal Information	
6.5 Electrical Characteristics	<mark>6</mark>
6.6 Switching Characteristics	7
6.7 Noise Characteristics	
6.8 Operating Characteristics	<mark>8</mark>
6.9 Typical Characteristics	
7 Parameter Measurement Information	
8 Detailed Description	10
8.1 Overview	

8.2 Functional Block Diagram	. 10
8.3 Feature Description	
8.4 Device Functional Modes	11
9 Applications and Implementation	
9.1 Application Information	
9.2 Typical Application	
10 Power Supply Recommendations	
11 Layout	
11.1 Layout Guidelines	
11.2 Layout Example	
12 Device and Documentation Support	
12.1 Documentation Support	
12.2 Receiving Notification of Documentation Updates.	
12.3 Support Resources	
12.4 Trademarks	
12.5 Electrostatic Discharge Caution	
12.6 Glossary	
13 Mechanical, Packaging, and Orderable	
Information	. 15

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

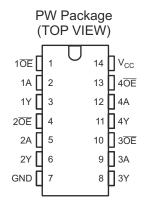
C	hanges from Revision B (March 2014) to Revision C (June 2022)	Page
•	I _{off} Support Partial-Power-Down Mode Operation to Features	1
•	Updated the numbering format for tables, figures, and cross-references throughout the document	1
•	Added ESD Ratings table, Receiving Notification of Documentation Updates section, and Support Reso	ources
	section	1

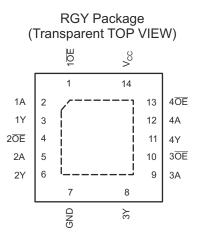
•	Updated Features.	
	Updated Pin Functions table.	
	Added ESD Ratings table, Thermal Information table, Typical Characteristics section, Pin Configuratio	
	Functions section, Detailed Description section, Power Supply Recommendations section, Layout sec	tion,
	Receiving Notification of Documentation Updates section, and Community Resources section	4
•	Updated Detailed Design Procedure section.	13
- c	hanges from Revision * (February 2014) to Revision A (March 2014)	Pag

_				,	,	
•	Updated 1 page	preview docur	nent to fu	ull version	 	1



5 Pin Configuration and Functions





Pin Functions

Р	IN	TYPE (1)	DESCRIPTION
NO.	NAME		DESCRIPTION
1	1 OE	I	Enable 1
2	1A	I	Input 1
3	1Y	0	Output 1
4	2 OE	I	Enable 2
5	2A	I	Input 2
6	2Y	0	Output 2
7	GND	_	Ground Pin
8	3Y	0	Output 3
9	3A	I	Input 3
10	3 OE	I	Enable 3
11	4Y	0	Output 4
12	4A	I	Input 4
13	4 OE		Enable 4
14	V _{CC}		Power Pin

(1) I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power.



6 Specifications 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7.0	V
VI	Input voltage range ⁽²⁾		-0.5	7.0	V
V	Voltage range applied to a	ny output in the high-impedance or power-off state ⁽²⁾	-0.5	4.6	V
Vo	Voltage range applied to a	ny output in the high or low state ⁽²⁾	-0.5	V _{CC} + 0.5	v
I _{IK}	Input clamp current	V ₁ < 0		-20	mA
I _{OK}	Output clamp current	V_{O} < 0 or V_{O} > V_{CC}		±50	mA
lo	Continuous output current			±35	mA
	Continuous current through	n V _{CC} or GND		±70	mA
TJ	Junction temperature			150	°C
T _{stg}	Storage temperature		-65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

6.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	
V _(ESD)	Electrostatic discharge	Machine Model (MM), per JEDEC specification	±200	v
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	±1000]

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.3 Recommended Operating Conditions

			MIN	MAX	UNIT
V _{CC}	Supply voltage		1.6	5.5	V
VI	Input voltage		0	5.5	V
Vo	Output voltage	High or Low State	0	V _{CC}	V
۷O	Ouput voltage	H-Z	0	V _{CC}	V
		V _{CC} = 1.8 V		-3	
	High lovel output ourrent	V _{CC} = 2.5 V		-5	mA
I _{OH}	High-level output current	V _{CC} = 3.3 V		-8	ma
		V _{CC} = 5.0 V		-16	
	Low-level output current	V _{CC} = 1.8 V		3	mA
		V _{CC} = 2.5 V		5	
I _{OL}		V _{CC} = 3.3 V		8	
		V _{CC} = 5.0 V		16	
		V _{CC} = 1.6 V to 2.0 V		20	
Δt/Δv	Input transition rise or fall rate	V _{CC} = 2.3 V to 2.7 V		20	ns/V
	Input transition rise or fall rate	V _{CC} = 3 V or 3.6 V		20	
		V _{CC} = 4.5 V to 5.0 V		20	
T _A	Operating free-air temperature		-40	125	°C

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

6.4 Thermal Information

		SN74L	V4T125	
	THERMAL METRIC ⁽¹⁾	PW	RGY	UNIT
		14 PINS	14 PINS	
R _{0JA}	Junction-to-ambient thermal resistance	126.9	52.9	
R _{0JCtop}	Junction-to-case (top) thermal resistance	54.2	67.8	
R _{θJB}	Junction-to-board thermal resistance	68.6	29.0	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	7.5	2.6	C/VV
Ψ _{JB}	Junction-to-board characterization parameter	68.0	29.1	
R _{0JCbot}	Junction-to-case (bottom) thermal resistance	_	9.3	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).



6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	V _{cc}	T _A :	= 25°C	T _A = -40°C to	125°C	UNIT
	FARAMETER	TEST CONDITIONS	VCC	MIN	TYP MAX	MIN	MAX	UNIT
			V _{CC} = 1.65 V to 1.9 V	0.95		1		
′ін	High-level input		V_{CC} = 2.3 V to 2.7 V	1.1		1.2		V
ΊΗ	voltage		V _{CC} = 3 V to 3.6 V	1.3		1.35		v
			V _{CC} = 4.5 V to 5.0 V	2		2		
	Low-level input ^{IL} voltage		V _{CC} = 1.65 V to 1.9 V		0.55		0.5	
,			V _{CC} = 2.3 V to 2.77 V		0.7		0.6	
∕ı∟			V _{CC} = 3 V to 3.6 V		0.85		0.75	V
			V _{CC} = 4.5 V to 5.5 V		0.9		0.85	
		Ι _{ΟΗ} = –50 μΑ	V _{CC} = 1.65 V to 5.5 V	V _{CC} – 0.1		V _{CC} - 0.1		V
		I _{OH} = –2 mA	V _{CC} = 1.65 V	1.4		1.35		V
		I _{OH} = –3 mA	V _{CC} = 2.3 V	2.05		2.0		V
V _{OH}	High-level output	I _{OH} = –5 mA		2.7		2.6		
	voltage	I _{OH} = –8 mA	V _{CC} = 3.0 V	2.6		2.5		V
		I _{OH} = –8 mA		3.7		3.6		
		I _{OH} = –16 mA	–– V _{CC} = 4.5 V	3.8		3.7		V
		I _{OH} = –16 mA	V _{CC} = 5.0 V	4.4		4.3		V
		I _{OL} = 50 μA	V _{CC} = 1.65 V to 5.5 V		0.1		0.1	V
			V _{CC} = 1.65 V		0.1		0.1	
		I _{OH} = 2 mA	V _{CC} = 1.8 V		0.2		0.3	V
	Low-level output voltage		V _{CC} = 2.3 V		0.2		0.3	
		I _{OH} = 3 mA	V _{CC} = 2.5 V		0.25		0.3	V
V _{OL}		I _{OH} = 5 mA			0.35		0.4	V
		I _{OH} = 8 mA	––– V _{CC} = 3.0 V		0.4		0.45	
		I _{OH} = 8 mA	V _{CC} = 3.3 V		0.45		0.5	V
		I _{OH} = 8 mA			0.50		0.55	
		I _{OH} = 16 mA	$V_{CC} = 4.5 V$	V _{CC} = 4.5 V 0.55		0.55	V	
		I _{OH} = 16 mA	V _{CC} = 5.0 V		0.55		0.55	V
I	Input leakage current	V _I =0 V or V _{CC}	V _{CC} = 0 V, 1.8 V, 2.5 V, 3.3 V, 5.5 V		±0.1		±1	μA
			V _{CC} = 5.0 V		2		20	
	Static supply	$V_1 = 0 V \text{ or } V_{CC}$	V _{CC} = 3.3 V		2		20	
lcc	current	$I_0 = 0$; open on loading	V _{CC} = 2.5 V		2		20	μA
			V _{CC} = 1.8 V		2		20	
AL	Additional static	One input at 0.3 V or 3.4 V Other inputs at 0 or V _{CC} , $I_0 = 0$	V _{CC} = 5.5 V		1.35		1.5	
∆l _{CC}	supply current	One input at 0.3 V or 1.1 V Other inputs at 0 or V _{CC} , $I_0 = 0$	V _{CC} = 1.8 V		1.00		1.5 µ/	μΑ
oz	Off-state (High Impedance State) Output Current	V _O = V _{CC} or GND	V _{CC} = 5.5 V		±0.25		±2.5	μA
off	Partial power down current	V_{O} or V_{I} = 0 to 5.5 V	V _{CC} = 0 V		0.5		5	μA
Ci	Input capacitance	V _I = V _{CC} or GND	V _{CC} = 3.3 V		1.6	1.6		pF
Co	Output capacitance	V _O = V _{CC} or GND	V _{CC} = 3.3 V		4.8	4.8		pF



6.6 Switching Characteristics

PARAMETER	FROM	то	FREQUENCY			٦	Γ _A = 25°C		T _A = -	65°C to 12	5°C						
PARAMETER	(INPUT)	(OUTPUT)	(TYP)	V _{cc}	CL	MIN	TYP	MAX	MIN	TYP	MAX	UNIT					
				5.0 V	15 pF		2.8	3.2		3	3.5						
t _{pd}			DC to 50 MHz	5.0 V	30 pF		3	3.5		3	4.5						
				3.3 V	15 pF		4	4.5		5	5.5	ns					
	Anyln	Y		3.3 V	30 pF		5	5.5		5.5	6.5						
t _{pd} Any	Any in	Ť	DC to 50 MHz	2.5 V	15 pF		5.5	6.5		7	7.5	20					
			DC to 50 MIHZ	2.5 V	30 pF		6.5	7		7.5	8.5	ns					
			DC to 30 MHz	1.8 V	15 pF		10	11		11	12	20					
			DC 10 30 MHZ	1.0 V	30 pF		11	12		12.5	13	ns					
				5.0 V	15 pF		3.5	4		3.5	4						
				5.0 V	30 pF		3.8	4.2		4	4.5						
			DC to 50 MHz	2.2.1	15 pF		5	5.8		5.8	6.1	ns					
		X		3.3 V	30 pF		5.5	6		5.7	6.5						
t _{PZH}		Y		0.5.1	15 pF		7.5	8		8.5	9						
			DC to 50 MHz	2.5 V	30 pF		8	8.5		9	9.5	ns					
				101/	15 pF		14.5	15		15.5	16.5	ns					
			DC to 30 MHz	1.8 V	30 pF		15.5	16		16	17						
t _{PZL}				5.0.1	15 pF		3	3.5		3.5	4						
			DC to 50 MHz	5.0 V	30 pF		3.5	4		4	4.5	ns					
				0.011	15 pF		5.3	5.6		6	6.2						
				3.3 V	30 pF		5.8	6.2		7	7.5						
	OE	Y			15 pF		8	8.5		9	9.5	ns					
			DC to 50 MHz	2.5 V	30 pF		9	9.5		10.5	11						
					15 pF		17	17.5		18	18 18.5						
			DC to 30 MHz	1.8 V	30 pF		18	18.5		19	20	ns					
					15 pF		3	3.5		3.5	4	_					
				5.0 V	30 pF		3.5	4		4	4.5						
									DC to 50 MHz				3.5	4		4.5	5
				3.3 V	30 pF		5	6		6.5	7						
t _{PHZ}	OE	Y			15 pF		5.5	6		6	6.5						
			DC to 50 MHz	2.5 V	30 pF		7.5	8		8	9	ns					
					15 pF		7.5	8		8	8.5						
			DC to 30 MHz	1.8 V			11	12		12	13	ns					
							2	2.5		2	2.7						
				5.0 V	30 pF		2	3		2	3.2						
			DC to 50 MHz		15 pF		2.3	2.8		2.5	3.2	ns					
				3.3 V	30 pF		2.8	3.2		3.3	4						
t _{PLZ}	OE	Y			15 pF		3.3	3.8		3.8	4.2						
			DC to 50 MHz	2.5 V	30 pF		4	4.3		4.2	5	ns					
					15 pF		5	5.5		5	5.7						
			DC to 30 MHz	1.8 V			6.5	7		7	8.5	ns					
			DC to 50 MHz	5.0 V to	15 pF												
t _{sk}	Any In	Y		2.5 V					1		1	ns					
		$ \overline{ OE} Y \left. \begin{array}{cccccccccccccccccccccccccccccccccccc$															

over operating free-air temperature range (unless otherwise noted) (see Figure 7-1)



6.7 Noise Characteristics

 V_{CC} = 3.3 V, C_{L} = 50 pF, T_{A} = 25°C⁽¹⁾

	PARAMETER	MIN	TYP	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.4	0.8	V
V _{OL(V)}	Quiet output, minimum dynamic V _{OL}		-0.3	-0.8	V
V _{OH(V)}	Quiet output, minimum dynamic V _{OH}		3		V
V _{IH(D)}	High-level dynamic input voltage	2.31			V
V _{IL(D)}	Low-level dynamic input voltage			0.99	V

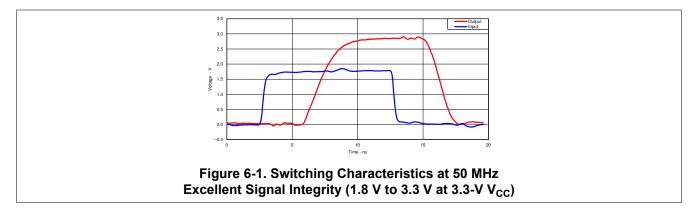
(1) Characteristics are for surface-mount packages only.

6.8 Operating Characteristics

V_{CC} = 5 V, T_A = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	C _L = 50 pF, f = 10 MHz	16	pF

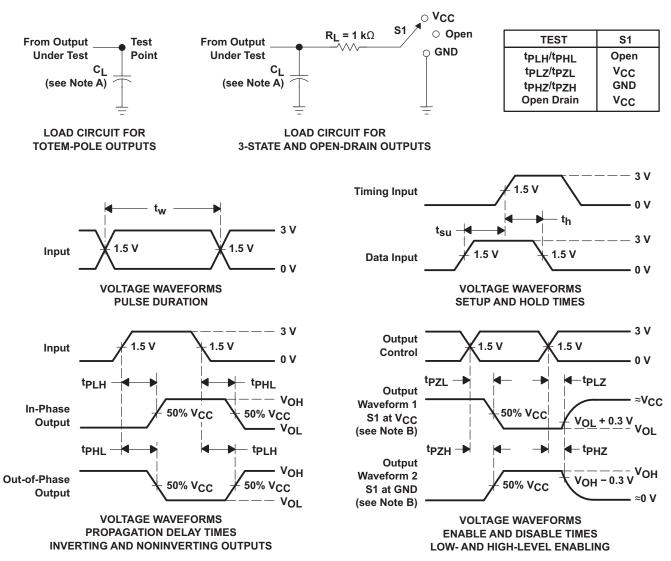
6.9 Typical Characteristics





7 Parameter Measurement Information

7.1



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r \leq 3 ns, t_f \leq 3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.



8 Detailed Description

8.1 Overview

The SN74LVxTxx family was created to allow up- or down-voltage translation with only one power rail. The family has over-voltage tolerant inputs that allow down translation from up to 5.5 V to the V_{CC} level that can be as low as 1.8 V. The family SN74LVxTxx also has a lowered switching threshold that allows it to translate up to the V_{CC} level that can be as high as 5.5 V.

8.1.1 Translating Down

Using these parts to translate down is very simple. Because the inputs are tolerant to 5.5 V at any valid V_{CC} , they can be used to down translate. The input can be any level above V_{CC} up to 5.5 V and the output will equal the V_{CC} level, which can be as low as 1.8 V. One important advantage to down translating using this part is that the I_{CC} current will remain less than or equal to the specified value.

Down translation possibilities with SN74LVxTxx:

- With 1.8-V V_{CC} from 2.5 V, 3.3 V, or 5 V down to 1.8 V.
- With 2.5-V V_{CC} from 3.3 V or 5 V down to 2.5 V.
- With 3.3-V V_{CC} from 5 V down to 3.3 V.

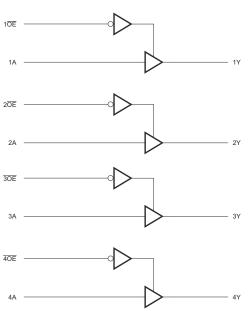
8.1.2 Translating Up

Using the SN74LVxTxx family to translate up is very simple. The input switching threshold is lowered so the high level of the input voltage can be much lower than a typical CMOS V_{IH}. For instance, If the V_{CC} is 3.3 V then the typical CMOS switching threshold would be V_{CC} / 2 or 1.65 V. This means the input high level must be at least V_{CC} × 0.7 or 2.31 V. On the LVxT devices the input threshold for 3.3-V V_{CC} is approximately 1 V. This allows a signal with a 1.8-V V_{IH} to be translated up to the V_{CC} level of 3.3 V.

Up translation possibilities with SN74LVxTxx:

- With 2.5-V V_{CC} from 1.8 V to 2.5 V.
- With 3.3-V V_{CC} from 1.8 V or 2.5 V to 3.3 V.
- With 5-V V_{CC} From 2.5 V or 3.3 V to 5 V.

8.2 Functional Block Diagram



8.3 Feature Description

This part is a single supply buffer that is capable up or down translation. The output will equal V_{CC} while the input can vary from 1.2 V to 5.5 V.



Up Translation Mode:

- 1.2 V to 1.8 V at 1.8-V V_{CC}
- 1.5 V to 2.5 V at 2.5-V V_{CC}
- 1.8 V to 3.3 V at 3.3-V V_{CC}
- 3.3 V to 5.0 V at 5.0-V V_{CC}

Down Translation Mode:

- 3.3 V to 1.8 V at 1.8-V V_{CC}
- 3.3 V to 2.5 V at 2.5-V V_{CC}
- 5.0 V to 3.3 V at 3.3-V V_{CC}

8.4 Device Functional Modes

This device performs the function of a buffer where input logic level equals the output logic level, while providing buffering and drive to the output. The SN74LV4T125 device will also translate voltages up or down while performing this function.

Table 8-1. Function Table (Each Buffer)

INPUT	OUTPUT ⁽²⁾	
ŌĒ	Α	Y
L	Н	Н
L	L	L
Н	Х	Z

Table 8-2. Supply V_{CC} = 3.3 V

	INPUT b (Lower Level Input)				
А	В	Y			
V _{IH} (min)	V _{OH} (min) = 2.9 V				
V _{IL} (max) = 0.8 V	V _{OL} (max) = 0.2 V			

 H = High Voltage Level, L = Low Voltage Level, X = Do not Care, Z = High Impedance

(2) H = Driving High, L = Driving Low, Z = High Impedance State



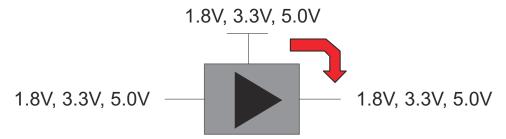
9 Applications and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

Based upon the lower-threshold circuit design of the LVxT family, the LVxT family also supports level translation. For level translation up and down, the LVxT family requires only a single power supply.



Standard Logic Mode 1.8V, 3.3V

9.2 Typical Application VIH = 2.0V VIL = 0.8V VIH = 0.99V VIL = 0.55V Vcc = 5.0V Vcc = 1.8V 5.0V, 3.3V 2.5V, 1.8V 1.5V, 1.2V System 5.0V 3.3V System 5.0V System 1.8V LV1Txx Logic LV1Txx Logic System Vcc = 3.3V 5.0V, 3.3V LV1Txx Logic 3.3V 2.5V, 1.8V System System VOH min = 2.4VVIH min = 1.36\ VOL max = 0.4V VIL min = 0.8V Figure 9-1. Switching Thresholds for 1.8 V to 3.3 V Translation



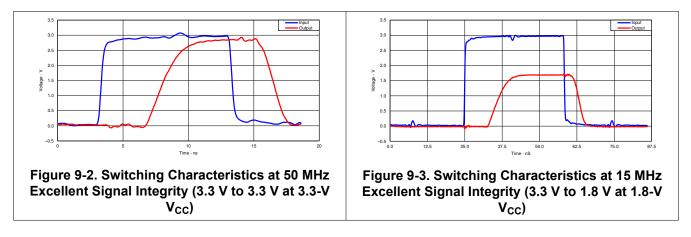
9.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. The input threshold levels are lowered to allow for up translation. At 5 V the device has equivalent TTL input levels.

9.2.2 Detailed Design Procedure

- 1. Recommended input conditions:
 - Rise time and fall time specifications. See ($\Delta t/\Delta V$) in *Recommended Operating Conditions* table.
 - Specified high and low levels. See (V_{IH} and V_{IL}) in *Recommended Operating Conditions* table.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V_{CC} .
- 2. Recommend output conditions:
 - Load currents should not exceed 35 mA per output and 70 mA total for the part.
 - Outputs should not be pulled above V_{CC}.

9.2.3 Application Curves



10 Power Supply Recommendations

The power supply can be any voltage between the Min and Max supply voltage rating located in the *Recommended Operating Conditions*.

Each V_{CC} pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1 μ F is recommended. If there are multiple V_{CC} pins, then 0.01 μ F or 0.022 μ F is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.



11 Layout 11.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified in Figure 11-1 are the rules that must be observed under all circumstances.

All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} whichever make more sense or is more convenient.

It is generally acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin it will disable the outputs section of the part when asserted. This will not disable the input section of the IOs so they also cannot float when disabled.

11.2 Layout Example



Figure 11-1. Layout Diagram



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Additional Product Selection

DEVICE	PACKAGE	DESCRIPTION
SN74LV1T00	DCK, DBV	2-Input Positive-NAND Gate
SN74LV1T02	DCK, DBV	2-Input Positive-NOR Gate
SN74LV1T04	DCK, DBV	Inverter Gate
SN74LV1T08	DCK, DBV	2-Input Positive-AND Gate
SN74LV1T34	DCK, DBV, DRL	Single Buffer Gate
SN74LV1T14	DCK, DBV	Single Schmitt-Trigger Inverter Gate
SN74LV1T32	DCK, DBV	2-Input Positive-OR Gate
SN74LV1T86	DCK, DBV	Single 2-Input Exclusive-Or Gate
SN74LV1T125	DCK, DBV, DRL	Single Buffer Gate with 3-state Output
SN74LV1T126	DCK, DBV, DRL	Single Buffer Gate with 3-state Output
SN74LV4T125	RGY, PW	Quadruple Bus Buffer Gate With 3-State Outputs

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

12.4 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LV4T125PWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LV4T125	Samples
SN74LV4T125RGYR	ACTIVE	VQFN	RGY	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	LVT125	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



www.ti.com

PACKAGE OPTION ADDENDUM

10-Dec-2020

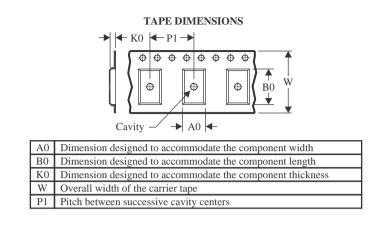


Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV4T125PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV4T125RGYR	VQFN	RGY	14	3000	330.0	12.4	3.75	3.75	1.15	8.0	12.0	Q1



www.ti.com

PACKAGE MATERIALS INFORMATION

3-Jun-2022



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV4T125PWR	TSSOP	PW	14	2000	364.0	364.0	27.0
SN74LV4T125RGYR	VQFN	RGY	14	3000	356.0	356.0	35.0

MECHANICAL DATA



- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- earrow Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated.
- The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



RGY (S-PVQFN-N14)

PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.

D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.

- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



A. An integration of the information o

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2022, Texas Instruments Incorporated